


<b>Search Notes</b>  	<b>Application/Control No.</b>  10567815	<b>Applicant(s)/Patent Under Reexamination</b>  HAN ET AL.
	<b>Examiner</b>  Scott D Long	<b>Art Unit</b>  1633

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
PALM inventor search	7/7/2008	SDL
EAST search - see attached sheet(s)	7/7/2008	SDL
STN search - see attached sheet(s)	7/7/2008	SDL

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner